
2SJ529(L), 2SJ529(S)

Silicon P Channel MOS FET
High Speed Power Switching

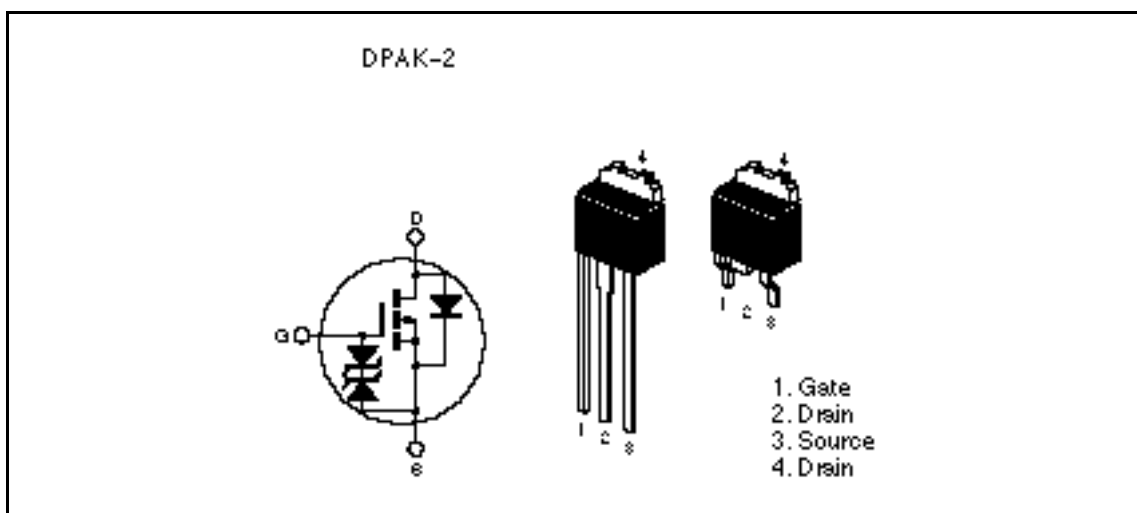
HITACHI

ADE-208-654A (Z)
2nd. Edition
Jun 1998

Features

- Σ Low on-resistance
 $R_{DS(on)} = 0.12 \text{ W typ.}$
- Σ 4 V gate drive devices
- Σ High speed switching

Outline



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Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit
Drain to source voltage	V_{DSS}	-60	V
Gate to source voltage	V_{GSS}	±20	V
Drain current	I_D	-10	A
Drain peak current	$I_{D(pulse)}$ ^{Note1}	-40	A
Body-drain diode reverse drain current	I_{DR}	-10	A
Avalanche current	I_{AP} ^{Note3}	-10	A
Avalanche energy	E_{AR} ^{Note3}	8.5	mJ
Channel dissipation	P_{ch} ^{Note2}	20	W
Channel temperature	T_{ch}	150	°C
Storage temperature	T_{stg}	-55 to +150	°C

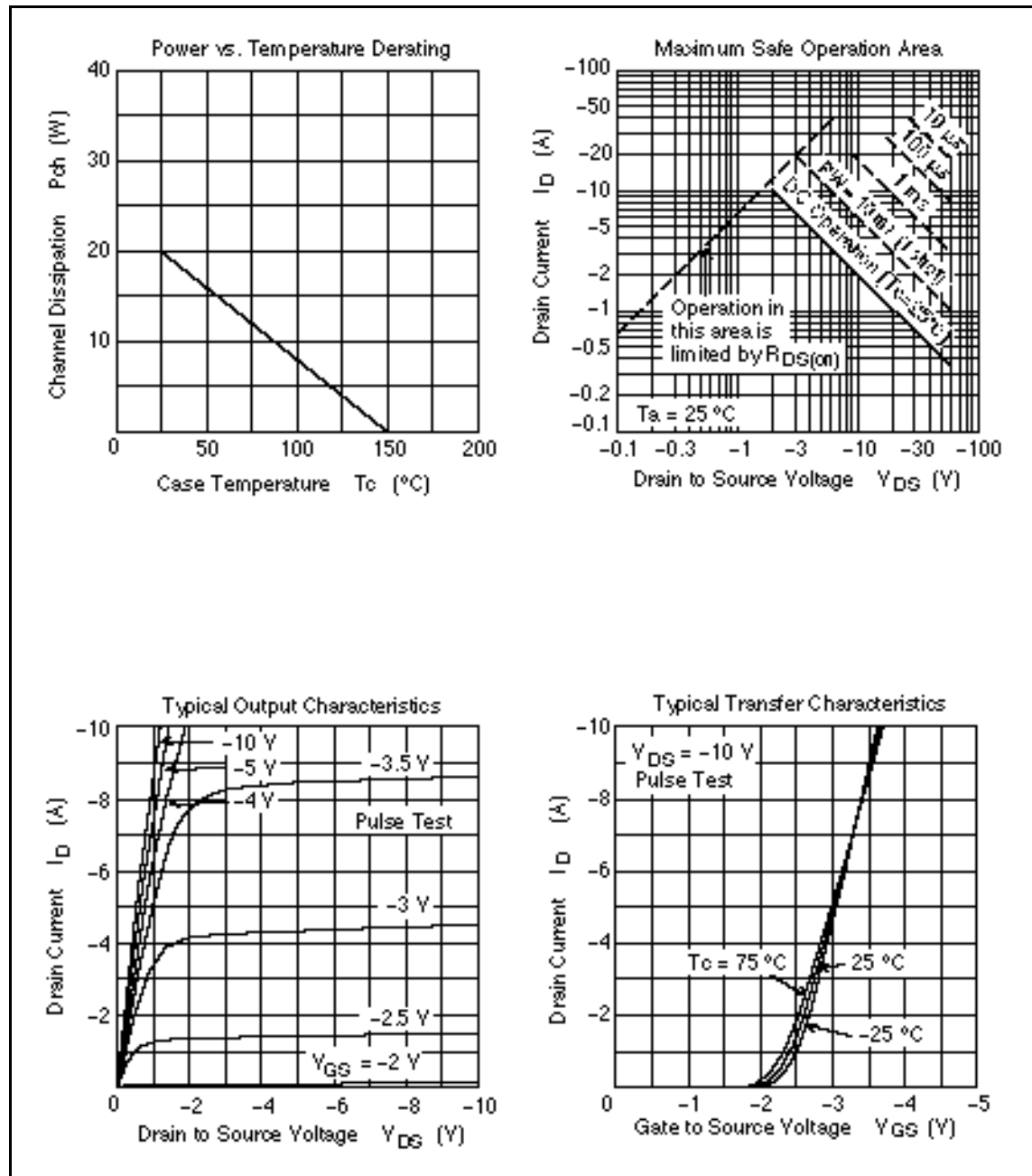
Note: 1. PW ≤ 10ms, duty cycle ≤ 1 %
2. Value at Tc = 25°C
3. Value at Tch = 25°C, Rg ≥ 50 W

Electrical Characteristics (Ta = 25°C)

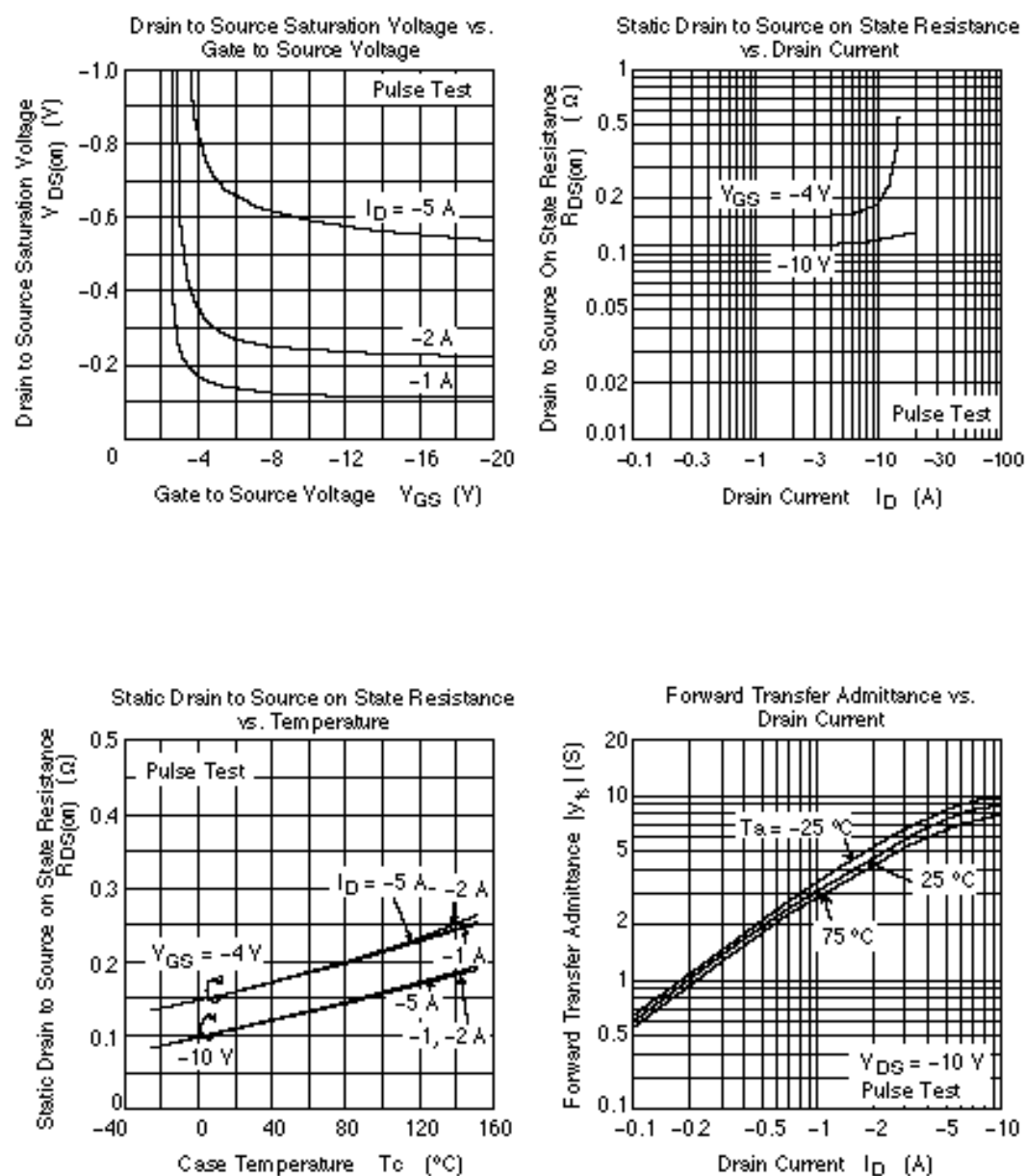
Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	-60	—	—	V	$I_D = -10mA, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	±20	—	—	V	$I_G = ±100mA, V_{DS} = 0$
Zero gate voltage drain current	I_{DSS}	—	—	-10	mA	$V_{DS} = -60V, V_{GS} = 0$
Gate to source leak current	I_{GSS}	—	—	±10	mA	$V_{GS} = ±16V, V_{DS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	-1.0	—	-2.0	V	$I_D = -1mA, V_{DS} = -10V$
Static drain to source on state resistance	$R_{DS(on)}$	—	0.12	0.16	W	$I_D = -5A, V_{GS} = -10V$ ^{Note4}
	$R_{DS(on)}$	—	0.17	0.24	W	$I_D = -5A, V_{GS} = -4V$ ^{Note4}
Forward transfer admittance	$ y_{fs} $	4.5	7.5	—	S	$I_D = -5A, V_{DS} = -10V$ ^{Note4}
Input capacitance	C_{iss}	—	580	—	pF	$V_{DS} = -10V$
Output capacitance	C_{oss}	—	300	—	pF	$V_{GS} = 0$
Reverse transfer capacitance	C_{rss}	—	85	—	pF	$f = 1MHz$
Turn-on delay time	$t_{d(on)}$	—	10	—	ns	$V_{GS} = -10V, I_D = -5A$
Rise time	t_r	—	40	—	ns	$R_L = 6W$
Turn-off delay time	$t_{d(off)}$	—	85	—	ns	
Fall time	t_f	—	60	—	ns	
Body-drain diode forward voltage	V_{DF}	—	-1.2	—	V	$I_F = -10A, V_{GS} = 0$
Body-drain diode reverse recovery time	t_{rr}	—	60	—	ns	$I_F = -10A, V_{GS} = 0$ $diF/dt = 50A/μs$

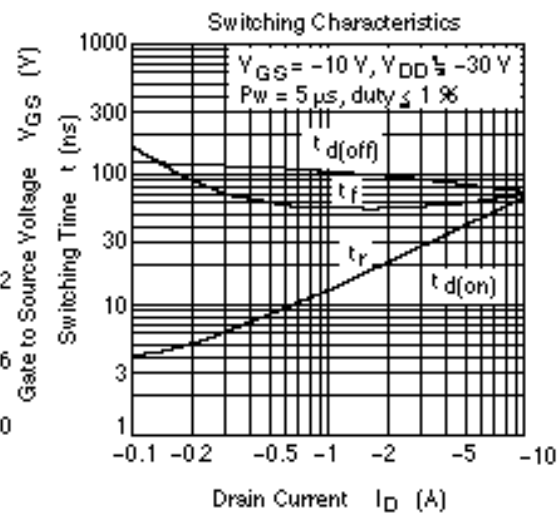
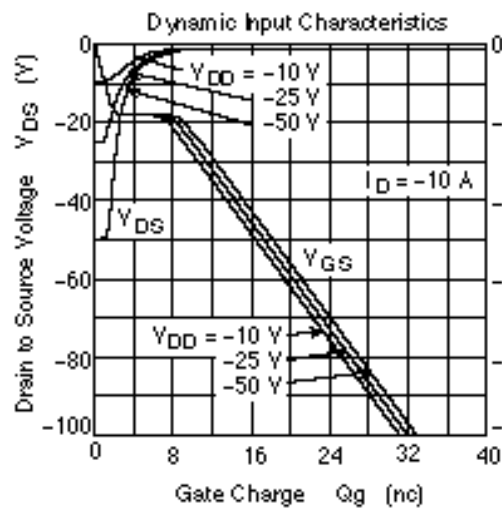
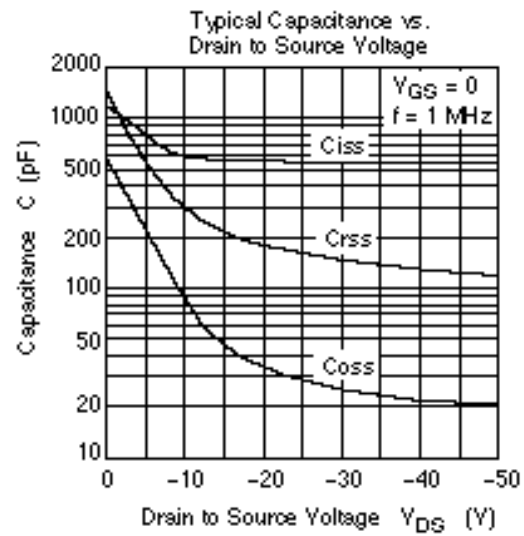
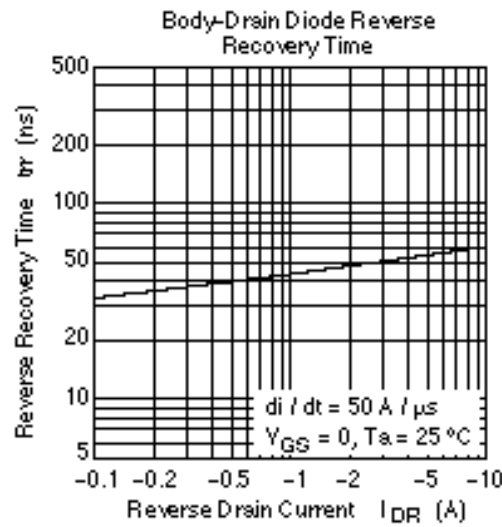
Note: 4. Pulse test

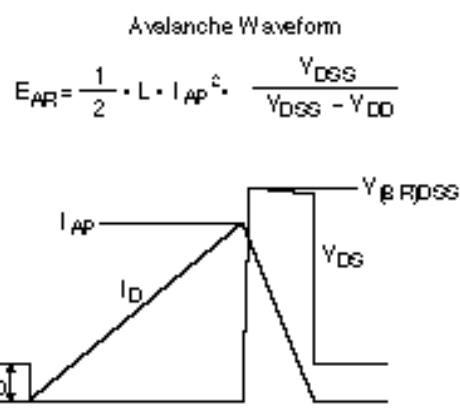
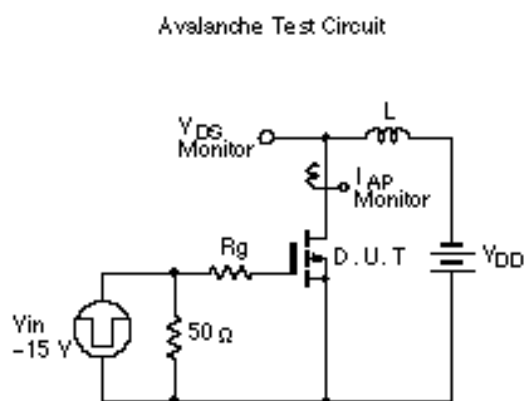
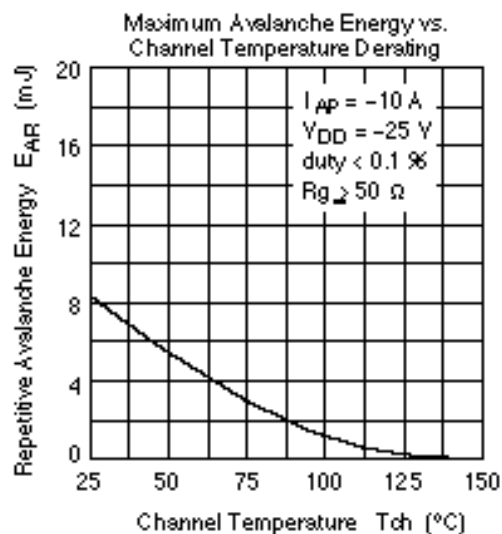
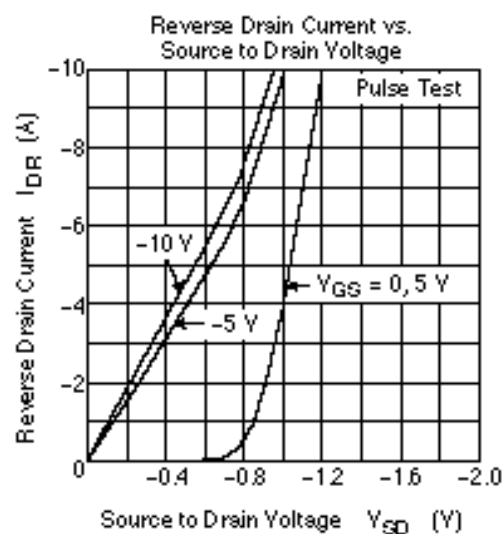
Main Characteristics

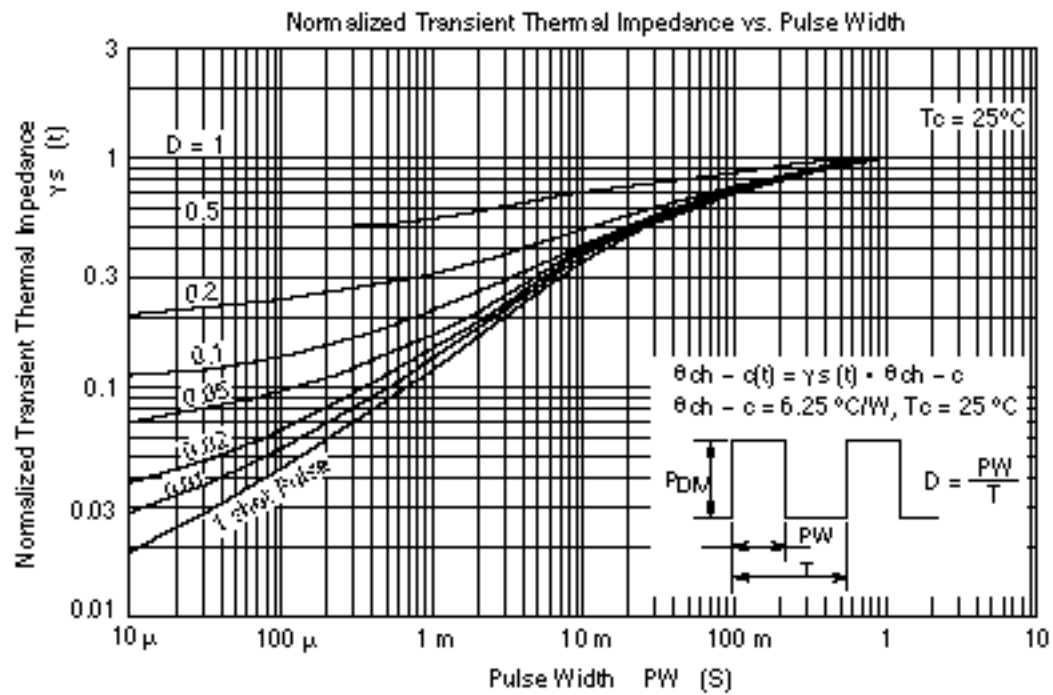


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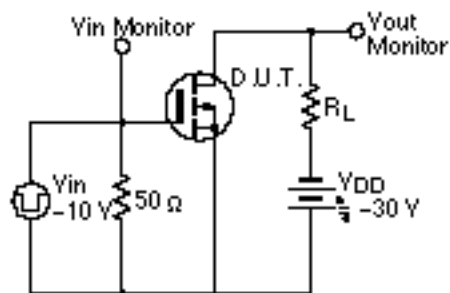




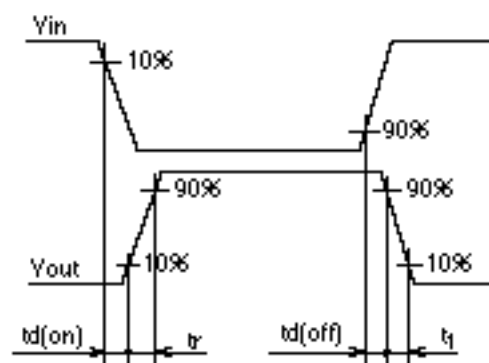




Switching Time Test Circuit



Waveform



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